


FORM PTO-1449		ATTY. DKT NO. 15-048	SER. NO. 10/800,725
APPLICANT TANAKA et al.			
FILING DATE March 16, 2004		GROUP 3661	

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS

FOREIGN PATENT DOCUMENTS

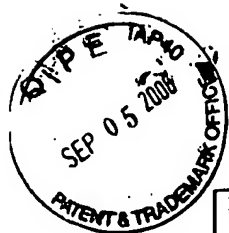
TRANSLATION

		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
										Eng. Abstract

* Full English text is available in machine-translated form in JPO (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

TN	Second Office Action from Chinese Patent Office issued on September 1, 2006 for the corresponding Chinese patent application No. 200410030128.9 (a copy and English translation thereof)	
EXAMINER	/Tan Q. Nguyen/	DATE CONSIDERED 10/29/2006



• PATENT APPLICATION

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		DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
										Eng. Abstract
TN		WO 01/34438	5/17/01	PCT				X		

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OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

TN	First Office Action from Chinese Patent Office issued on March 3, 2006 for the corresponding Chinese patent application No. 200410030128.9 (a copy and English translation thereof)	
EXAMINER	/Tan Q. Nguyen/	DATE CONSIDERED 06/13/2006